

Notice of References Cited	Application/Control No. 10/676,099		Applicant(s)/Patent Under Reexamination RABACH ET AL.	
	Examiner Anjan K. Deb		Art Unit 2858	Page 1 of 1

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	B	US-4,949,001 A	08-1990	Campbell, Steven R.	310/220
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NON-PATENT DOCUMENTS

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	U	David M. Pozar "Microwave Engineering" page 2, Figure 1.1 The electromagnetic spectrum
	V	IEEE Authoritative Dictionary of IEEE Standard terms, page 41, 7th Edition, IEEE Press
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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